

Application/Control No.	Applicant(s)/Patent under Reexamination
10/759,640	CHAIKEN ET AL.
Examiner	Art Unit
Eric Chang	2116

SEARCHED					
Class	Subclass	Date	Examiner		
713	320	9/25/2007	EC		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
713	320	9/26/2007	EC	
PGPUB t	ext search	9/26/2007	EC	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST USPAT/PGPUB EPO/JPO	9/25/2007	EC	
Consulted Examiner James Trujillo	9/27/2007	EC	
Inventor name search	9/27/2007	EC	
EAST text search 713/320	9/27/2007	EC	